



SEMITRANS® 5

## Trench IGBT Modules

### SKM200MLI066TAT

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- Integrated NTC temperature sensor

#### Typical Applications\*

- UPS
- 3 Level Inverter

#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max
- Recommended  $T_{op} = -40..+150^\circ\text{C}$
- $T_{vj}$  is intended as absolute maximum rating
- Fig.2 is referred to IGBT current capability



MLI-TAT

Absolute Maximum Ratings				$T_{case} = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions			Values	Units
<b>IGBT</b>					
$V_{CES}$	$T_j = 25^\circ\text{C}$			600	V
$I_C$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$		280	A
		$T_c = 80^\circ\text{C}$		210	A
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$			400	A
$V_{GES}$				$\pm 20$	V
$t_{psc}$	$V_{CC} = 360\text{ V}; V_{GE} \leq 15\text{ V}; T_j = 150^\circ\text{C}$ $V_{CES} < 600\text{ V}$			6	$\mu\text{s}$
<b>Inverse Diode</b>					
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$		270	A
		$T_c = 80^\circ\text{C}$		200	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$			400	A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$			1310	A
<b>Freewheeling Diode</b>					
$I_F$	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$		270	A
		$T_c = 80^\circ\text{C}$		200	A
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$			400	A
$I_{FSM}$	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150^\circ\text{C}$			1310	A
<b>Module</b>					
$I_{t(RMS)}$				500	A
$T_{vj}$				- 40 ... + 175	$^\circ\text{C}$
$T_{stg}$				- 40 ... + 125	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.			2500	V

Characteristics			T <sub>case</sub> = 25°C, unless otherwise specified			
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 3,2 mA		5	5,8	6,5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = V <sub>CES</sub>	T <sub>j</sub> = 25 °C			0,5	mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 25 °C			1200	nA
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0,9	1	V
		T <sub>j</sub> = 150 °C		0,7	0,8	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		2,7	4,5	mΩ
		T <sub>j</sub> = 150°C		5	6,5	mΩ
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 200 A, V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C <sub>chiplev.</sub>		1,45	1,9	V
		T <sub>j</sub> = 150°C <sub>chiplev.</sub>		1,7	2,1	V
C <sub>ies</sub>	V <sub>CE</sub> = 25, V <sub>GE</sub> = 0 V	f = 1 MHz		12,3		nF
C <sub>oes</sub>				0,76		nF
C <sub>res</sub>				0,36		nF
Q <sub>G</sub>	V <sub>GE</sub> = -15V...+15V			2254		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			1		Ω
t <sub>d(on)</sub>	R <sub>Gon</sub> = 22 Ω di/dt = 2000 A/μs	V <sub>CC</sub> = 300V I <sub>C</sub> = 200A		78		ns
t <sub>r</sub>				68		ns
E <sub>on</sub>	R <sub>Goff</sub> = 1 Ω di/dt = 2000 A/μs	T <sub>j</sub> = 150 °C V <sub>GE</sub> = -15V/+15V		2,53		mJ
t <sub>d(off)</sub>				314		ns
t <sub>f</sub>				80		ns
E <sub>off</sub>				6,82		mJ
R <sub>th(j-c)</sub>	per IGBT			0,21		K/W



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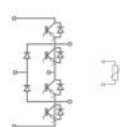
### Remarks

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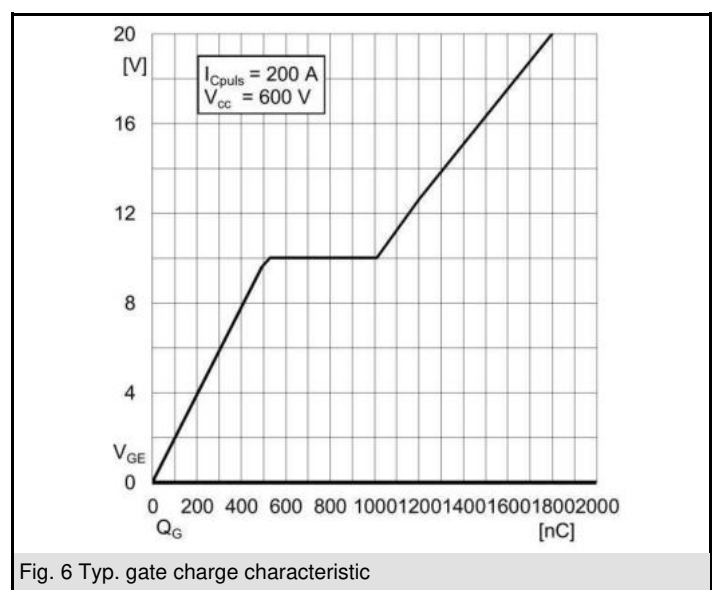
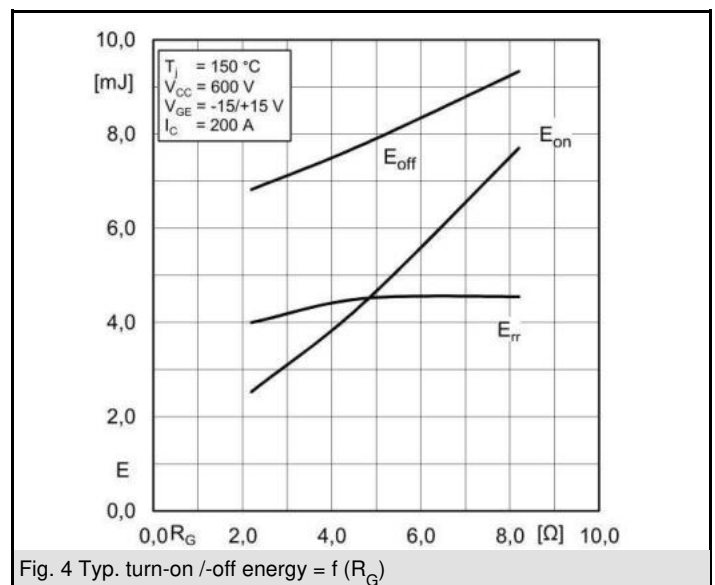
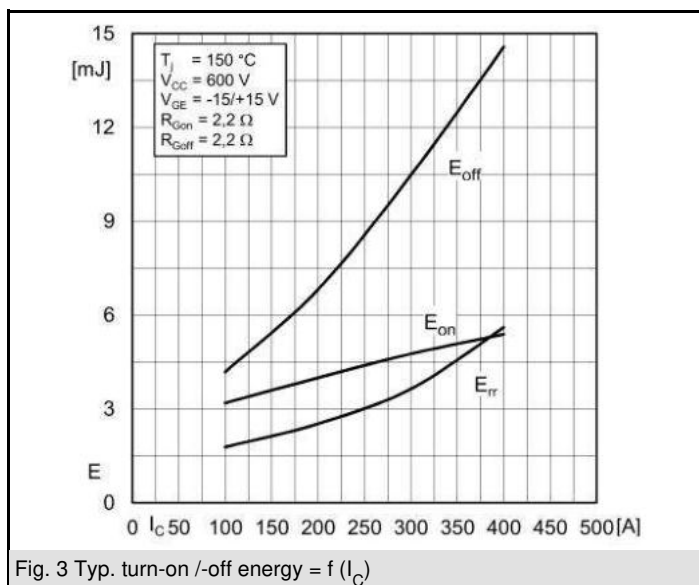
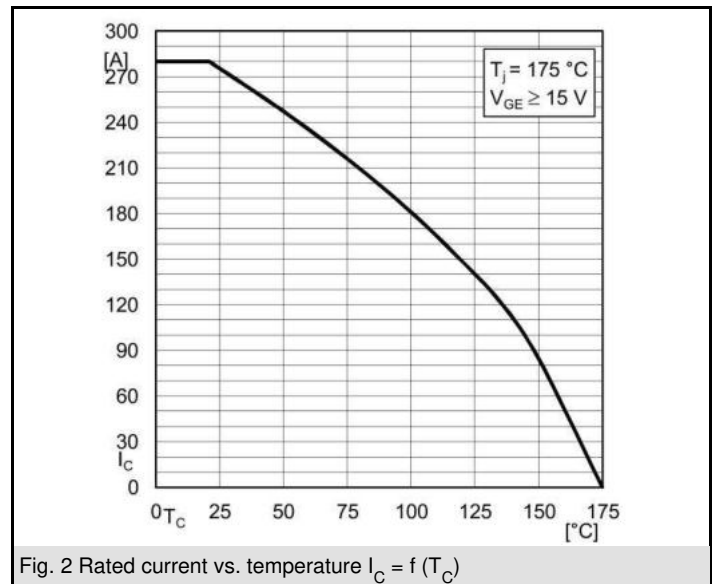
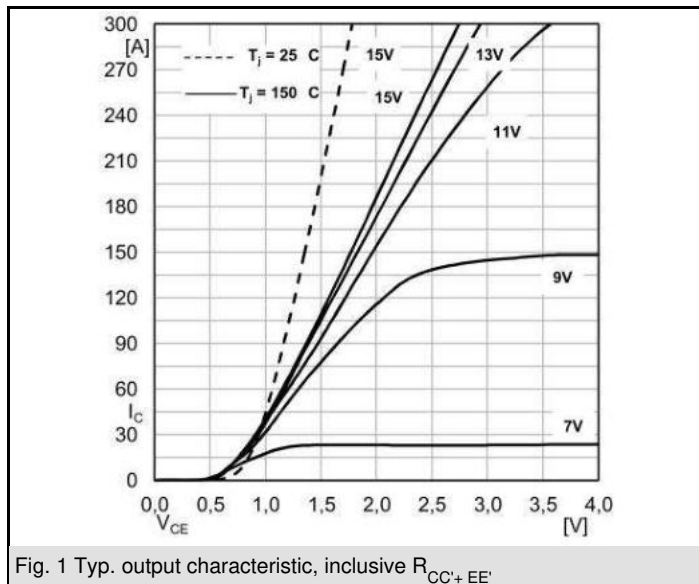
Characteristics						
Symbol	Conditions	min.	typ.	max.	Units	
Inverse Diode						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>Fnom</sub> = 200 A; V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>	1,4	1,6	V	
		T <sub>j</sub> = 150 °C <sub>chiplev.</sub>	1,4	1,6	V	
V <sub>F0</sub>		T <sub>j</sub> = 25 °C	0,95	1	V	
		T <sub>j</sub> = 150 °C	0,85	0,9	V	
r <sub>F</sub>		T <sub>j</sub> = 25 °C	2	3	mΩ	
		T <sub>j</sub> = 150 °C	2,7	3,5	mΩ	
I <sub>RRM</sub> Q <sub>rr</sub> E <sub>rr</sub>	I <sub>F</sub> = 200 A di/dt = 2000 A/μs V <sub>GE</sub> = -15... +15 V; V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C				A μC mJ
R <sub>th(j-c)D</sub>	per diode		0,39			K/W
Free-wheeling diode (Neutral Clamp Diode)						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>Fnom</sub> = 200 A; V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>	1,4	1,6	V	
		T <sub>j</sub> = 150 °C <sub>chiplev.</sub>	1,4	1,6	V	
V <sub>F0</sub>		T <sub>j</sub> = 25 °C	0,95	1	V	
		T <sub>j</sub> = 150 °C	0,85	0,9	V	
r <sub>F</sub>		T <sub>j</sub> = 25 °C	2	3	V	
		T <sub>j</sub> = 150 °C	2,7	3,5	V	
I <sub>RRM</sub> Q <sub>rr</sub> E <sub>rr</sub>	I <sub>F</sub> = 200 A di/dt = 2000 A/μs V <sub>GE</sub> = -15...+15 V; V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C	175,8 12 4	A μC mJ		
R <sub>th(j-c)FD</sub>	per diode		0,39			K/W
R <sub>th(c-s)</sub>	per module		0,038			K/W
M <sub>s</sub>	to heat sink M6		3	5	Nm	
M <sub>t</sub>	to terminals M6		2,5	5	Nm	
w				310	g	
Temperature sensor						
R <sub>100</sub>	T <sub>s</sub> =100°C (R <sub>25</sub> =5kΩ)		493±5%			Ω K

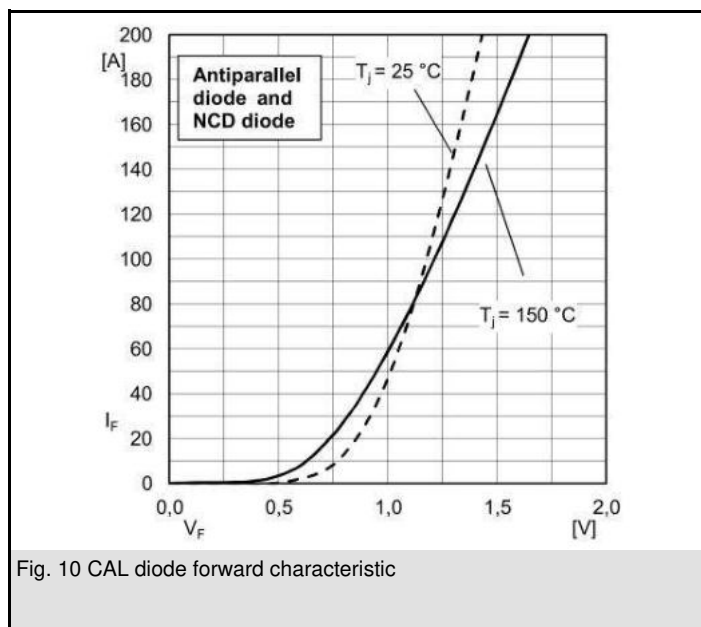
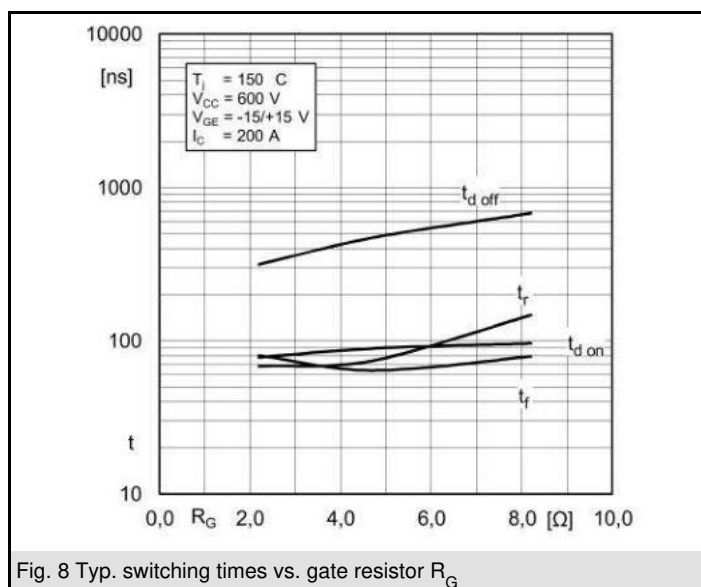
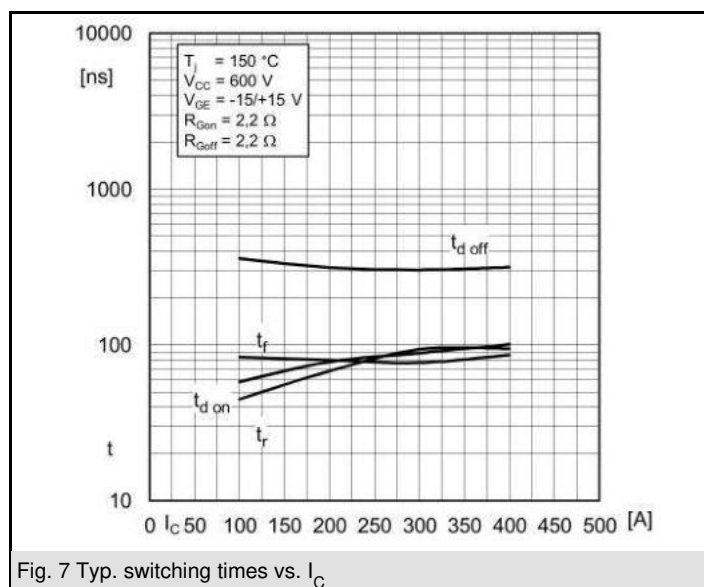
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.



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